

MOS FIELD EFFECT TRANSISTOR 2SK3358

SWITCHING N-CHANNEL POWER MOS FET INDUSTRIAL USE

DESCRIPTION

The 2SK3358 is N-Channel MOS Field Effect Transistor designed for high current switching applications.

FEATURES

- · Low on-state resistance
 - $R_{DS(on)1} = 30 \text{ m}\Omega \text{ MAX.} \text{ (Vgs} = 10 \text{ V, ID} = 28 \text{ A)}$
- \star RDS(on)2 = 40 m Ω MAX. (VGS = 4.5 V, ID = 20 A)
- ★ Low Ciss: Ciss = 3200 pF TYP.
 - Built-in gate protection diode

ORDERING INFORMATION

PART NUMBER	PACKAGE
2SK3358	TO-220AB
2SK3358-S	TO-262
2SK3358-Z	TO-220SMD

(TO-220AB)

ABSOLUTE MAXIMUM RATINGS (TA = 25 °C)

	Drain to Source Voltage (Vgs = 0 V)	VDSS	100	V
	Gate to Source Voltage (Vps = 0 V)	VGSS(AC)	±20	V
	Gate to Source Voltage (Vps = 0 V)	VGSS(DC)	+20, -10	V
	Drain Current (DC)	ID(DC)	±55	Α
*	Drain Current (Pulse) Note1	I _{D(pulse)}	±165	Α
	Total Power Dissipation (Tc = 25°C)	Рт	100	W
	Total Power Dissipation (T _A = 25°C)	Рт	1.5	W
	Channel Temperature	Tch	150	°C
	Storage Temperature	T_{stg}	-55 to +150	°C
	Single Avalanche Current Note2	IAS	39	Α
	Single Avalanche Energy Note2	Eas	152	mJ

Notes 1. PW \leq 10 μ s, Duty cycle \leq 1 %

2. Starting Tch = 25 °C, Rg = 25 Ω , Vgs = 20 V \rightarrow 0 V



(TO-262)



(TO-220SMD)



THERMAL RESISTANCE

Channel to Case $R_{th(ch-C)}$ 1.25 °C/W Channel to Ambient $R_{th(ch-A)}$ 83.3 °C/W

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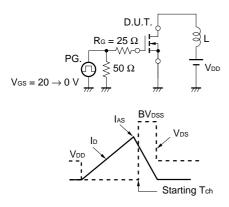
Not all devices/types available in every country. Please check with local NEC representative for availability and additional information.



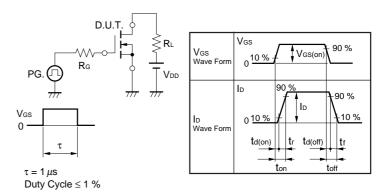
ELECTRICAL CHARACTERISTICS (TA = 25 °C)

CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Drain to Source On-state Resistance	RDS(on)1	Vgs = 10 V, ID = 28 A		20	30	mΩ
	RDS(on)2	V _G S = 4.5 V, I _D = 20 A		28	40	mΩ
Gate to Source Cut-off Voltage	V _{GS(off)}	$V_{DS} = 10 \text{ V}, I_{D} = 250 \mu\text{A}$	1.5	2.0	2.5	V
Forward Transfer Admittance	yfs	V _{DS} = 10 V, I _D = 28 A	17	35		S
Drain Leakage Current	Ipss	V _{DS} = 100 V, V _{GS} = 0 V			10	μΑ
Gate to Source Leakage Current	Igss	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			±10	μΑ
Input Capacitance	Ciss	Vps = 10 V		3200		pF
Output Capacitance	Coss	Vgs = 0 V		640		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		360		pF
Turn-on Delay Time	t _{d(on)}	ID = 28 A		40		ns
Rise Time	tr	VGS(on) = 10 V		300		ns
Turn-off Delay Time	td(off)	VDD = 50 V		220		ns
Fall Time	t f	$R_G = 10 \Omega$		230		ns
Total Gate Charge	QG	ID = 55 A		84		nC
Gate to Source Charge	Qgs	V _{DD} = 80		11		nC
Gate to Drain Charge	Q _{GD}	V _{GS(on)} = 10 V		31		nC
Body Diode Forward Voltage	V _F (S-D)	IF = 55 A, VGS = 0 V		1.0		V
Reverse Recovery Time	trr	IF = 55 A, VGS = 0 V		160		ns
Reverse Recovery Charge	Qır	di/dt = 100 A/μs		760		nC

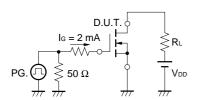
TEST CIRCUIT 1 AVALANCHE CAPABILITY



TEST CIRCUIT 2 SWITCHING TIME



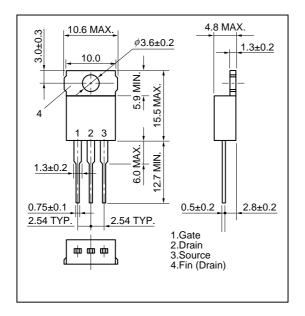
TEST CIRCUIT 3 GATE CHARGE



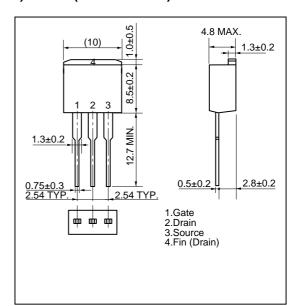


PACKAGE DRAWINGS (Unit: mm)

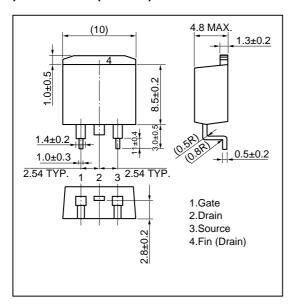
1)TO-220AB (MP-25)



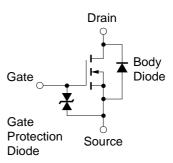
2)TO-262 (MP-25 Fin Cut)



3)TO-220SMD (MP-25Z)



EQUIVALENT CIRCUIT



Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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